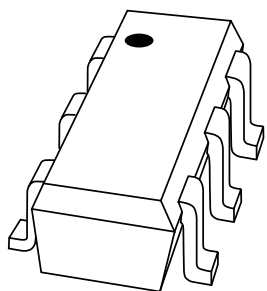


DATA SHEET



BF1206

Dual N-channel dual-gate
MOS-FET

Product specification

2003 Nov 17



Dual N-channel dual-gate MOS-FET

BF1206

FEATURES

- Two low noise gain controlled amplifiers in a single package
- Superior cross-modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio.

APPLICATIONS

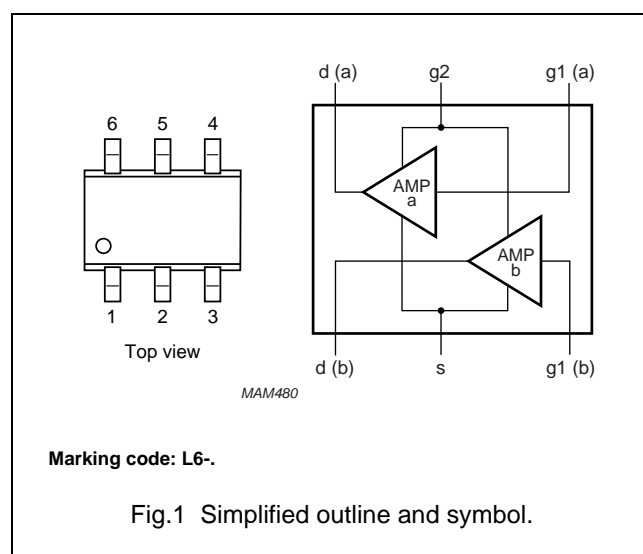
- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage, such as digital and analog television tuners.

DESCRIPTION

The BF1206 is a combination of two different dual gate MOS-FET amplifiers with shared source and gate 2 leads. The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross-modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor is encapsulated in SOT363 micro-miniature plastic package.

PINNING - SOT363

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | drain (b) |
| 2 | source |
| 3 | gate 1 (b) |
| 4 | gate 1 (a) |
| 5 | gate 2 |
| 6 | drain (a) |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|------------------------------|--|------|------|------|------------|
| Per MOS-FET; unless otherwise specified | | | | | | |
| V_{DS} | drain-source voltage | | — | — | 6 | V |
| I_D | drain current (DC) | | — | — | 30 | mA |
| $ y_{fs} $ | forward transfer admittance | amp. a: $I_D = 18$ mA | 33 | 38 | 48 | mS |
| | | amp. b: $I_D = 12$ mA | 29 | 34 | 44 | mS |
| C_{ig1-s} | input capacitance at gate 1 | amp. a: $I_D = 18$ mA; $f = 1$ MHz | — | 2.4 | 2.9 | pF |
| | | amp. b: $I_D = 12$ mA; $f = 1$ MHz | — | 1.7 | 2.2 | pF |
| C_{rss} | reverse transfer capacitance | $f = 1$ MHz | — | 15 | — | fF |
| X_{mod} | cross-modulation | amp. a: input level for $k = 1\%$ at 40 dB AGC | 102 | 105 | — | dB μ V |
| | | amp. b: input level for $k = 1\%$ at 40 dB AGC | 100 | 103 | — | dB μ V |
| NF | noise figure | amp. a: $f = 400$ MHz; $I_D = 18$ mA | — | 1.3 | 1.9 | dB |
| | | amp. b: $f = 800$ MHz; $I_D = 12$ mA | — | 1.4 | 2.0 | dB |
| | | amp. a: $f = 11$ MHz; $I_D = 18$ mA | — | 3 | — | dB |
| | | amp. b: $f = 11$ MHz; $I_D = 12$ mA | — | 3.5 | — | dB |

Dual N-channel dual-gate MOS-FET

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CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

ORDERING INFORMATION

| TYPE NUMBER | PACKAGE | | |
|-------------|---------|--|---------|
| | NAME | DESCRIPTION | VERSION |
| BF1206 | – | plastic surface mounted package; 6 leads | SOT363 |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--|-------------------------|-----------------------------------|------|----------|------|
| Per MOS-FET; unless otherwise specified | | | | | |
| V_{DS} | drain-source voltage | | – | 6 | V |
| I_D | drain current (DC) | | – | 30 | mA |
| I_{G1} | gate 1 current | | – | ± 10 | mA |
| I_{G2} | gate 2 current | | – | ± 10 | mA |
| P_{tot} | total power dissipation | $T_s \leq 107\text{ °C}$; note 1 | – | 180 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 150 | °C |

Note

1. T_s is the temperature at the soldering point of the source lead.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | 240 | K/W |

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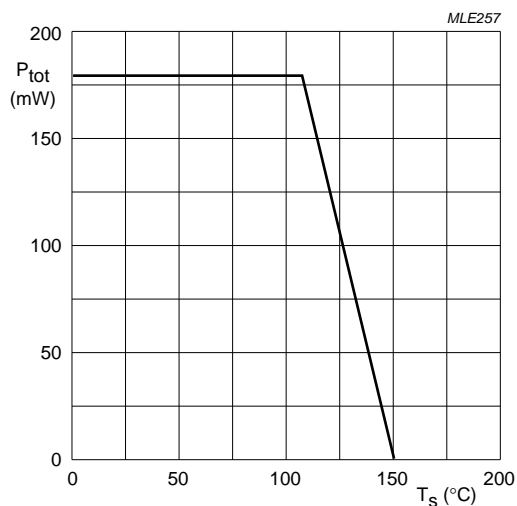


Fig.2 Power derating curve.

STATIC CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---|--------------------------------|--|------|------|------|
| Per MOS-FET unless otherwise specified | | | | | |
| V _{(BR)DSS} | drain-source breakdown voltage | V _{G1-S} = V _{G2-S} = 0; I _D = 10 μA | 6 | – | V |
| V _{(BR)G1-SS} | gate-source breakdown voltage | V _{GS} = V _{DS} = 0; I _{G1-S} = 10 mA | 6 | 10 | V |
| V _{(BR)G2-SS} | gate-source breakdown voltage | V _{GS} = V _{DS} = 0; I _{G2-S} = 10 mA | 6 | 10 | V |
| V _{(F)S-G1} | forward source-gate voltage | V _{G2-S} = V _{DS} = 0; I _{S-G1} = 10 mA | 0.5 | 1.5 | V |
| V _{(F)S-G2} | forward source-gate voltage | V _{G1-S} = V _{DS} = 0; I _{S-G2} = 10 mA | 0.5 | 1.5 | V |
| V _{G1-S(th)} | gate-source threshold voltage | V _{DS} = 5 V; V _{G2-S} = 4 V; I _D = 100 μA | 0.3 | 1 | V |
| V _{G2-S(th)} | gate-source threshold voltage | V _{DS} = 5 V; V _{G1-S} = 5 V; I _D = 100 μA | 0.35 | 1 | V |
| I _{DSX} | drain-source current | amp. a: V _{G2-S} = 4 V; V _{DS} = 5 V; R _G = 91 kΩ; note 1 | 14 | 23 | mA |
| | | amp. b: V _{G2-S} = 4 V; V _{DS} = 5 V; R _G = 150 kΩ; note 1 | 9 | 17 | mA |
| I _{G1-S} | gate cut-off current | V _{G1-S} = 5 V; V _{G2-S} = V _{DS} = 0 | – | 50 | nA |
| I _{G2-S} | gate cut-off current | V _{G2-S} = 5 V; V _{G1-S} = V _{DS} = 0 | – | 20 | nA |

Note

1. R_{G1} connects gate 1 to V_{GG} = 5 V.

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DYNAMIC CHARACTERISTICS AMPLIFIER aCommon source; $T_{amb} = 25\text{ }^{\circ}\text{C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS} = 5\text{ V}$; $I_D = 18\text{ mA}$; unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|------------------------------|---|------|------|------|------------|
| $ Y_{fs} $ | forward transfer admittance | pulsed; $T_j = 25\text{ }^{\circ}\text{C}$ | 33 | 38 | 48 | mS |
| C_{ig1-ss} | input capacitance at gate 1 | $f = 1\text{ MHz}$ | – | 2.4 | 2.9 | pF |
| C_{ig2-ss} | input capacitance at gate 2 | $f = 1\text{ MHz}$ | – | 3.2 | – | pF |
| C_{oss} | output capacitance | $f = 1\text{ MHz}$ | – | 1.1 | – | pF |
| C_{rss} | reverse transfer capacitance | $f = 1\text{ MHz}$ | – | 15 | 30 | fF |
| NF | noise figure | $f = 11\text{ MHz}$; $G_S = 20\text{ mS}$; $B_S = 0$ | – | 3 | – | dB |
| | | $f = 400\text{ MHz}$; $Y_S = Y_{S\text{ opt}}$ | – | 1.3 | 1.9 | dB |
| | | $f = 800\text{ MHz}$; $Y_S = Y_{S\text{ opt}}$ | – | 1.6 | 2.2 | dB |
| G_{tr} | power gain | $f = 200\text{ MHz}$; $G_S = 2\text{ mS}$; $B_S = B_{S\text{ opt}}$; $G_L = 0.5\text{ mS}$; $B_L = B_{L\text{ opt}}$; note 1 | – | 35 | – | dB |
| | | $f = 400\text{ MHz}$; $G_S = 2\text{ mS}$; $B_S = B_{S\text{ opt}}$; $G_L = 1\text{ mS}$; $B_L = B_{L\text{ opt}}$; note 1 | – | 30 | – | dB |
| | | $f = 800\text{ MHz}$; $G_S = 3.3\text{ mS}$; $B_S = B_{S\text{ opt}}$; $G_L = 1\text{ mS}$; $B_L = B_{L\text{ opt}}$; note 1 | – | 23 | – | dB |
| X_{mod} | cross-modulation | input level for $k = 1\%$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$; note 2 | | | | |
| | | at 0 dB AGC | 90 | – | – | dB μ V |
| | | at 10 dB AGC | – | 92 | – | dB μ V |
| | | at 40 dB AGC | 102 | 105 | – | dB μ V |

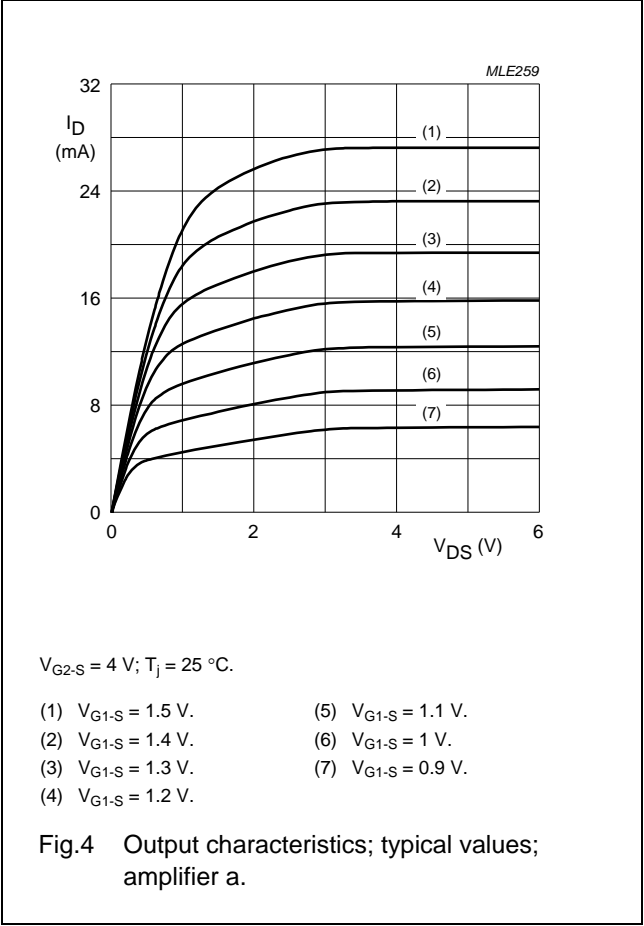
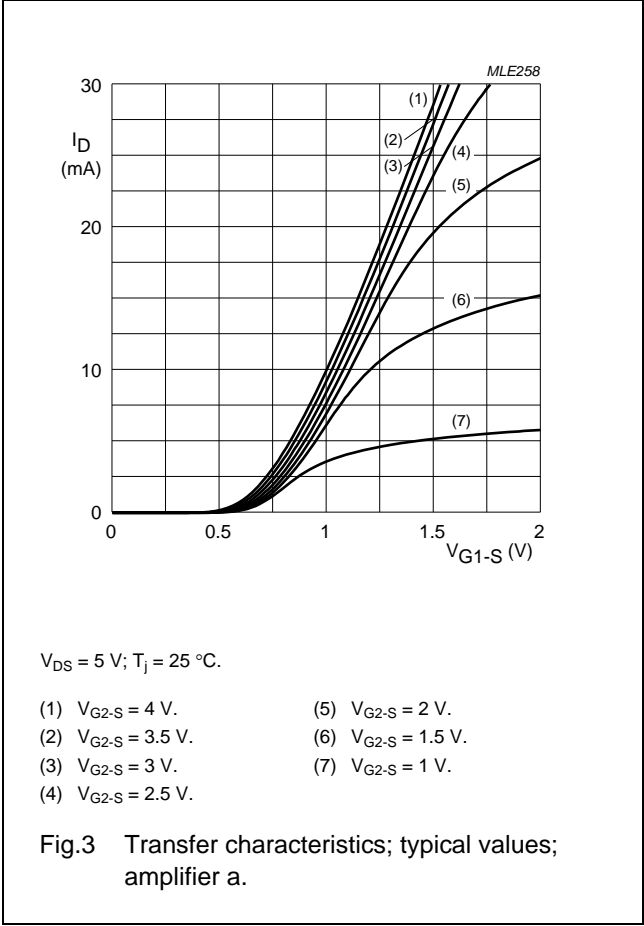
Notes

1. Calculated from measured s-parameters.
2. Measured in Fig.35 test circuit.

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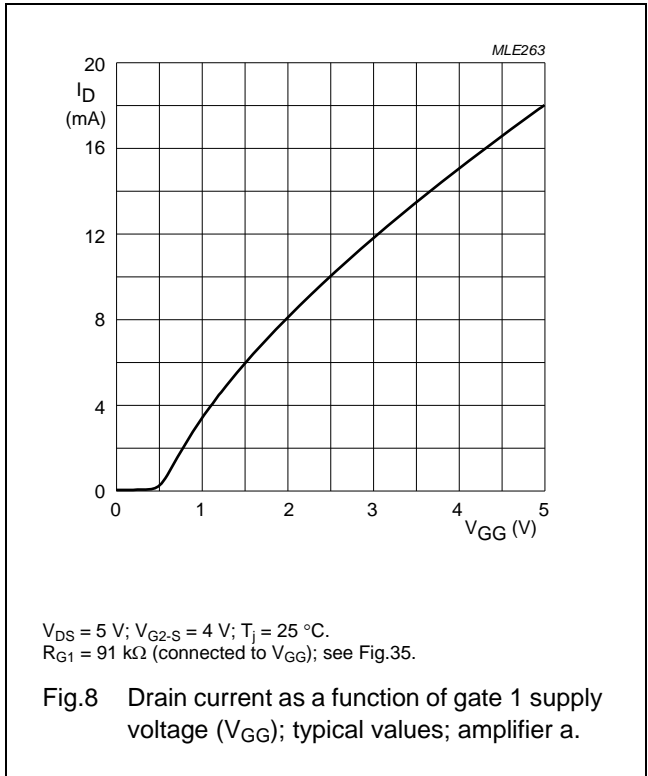
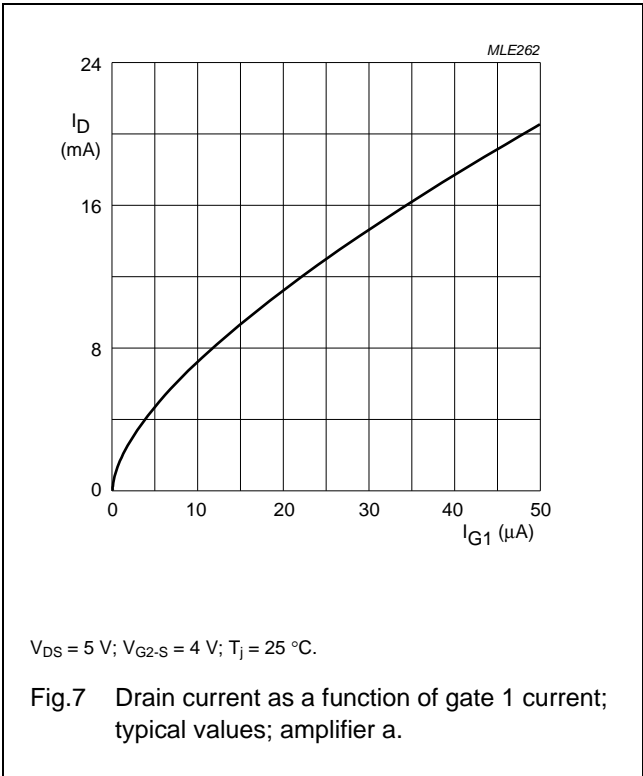
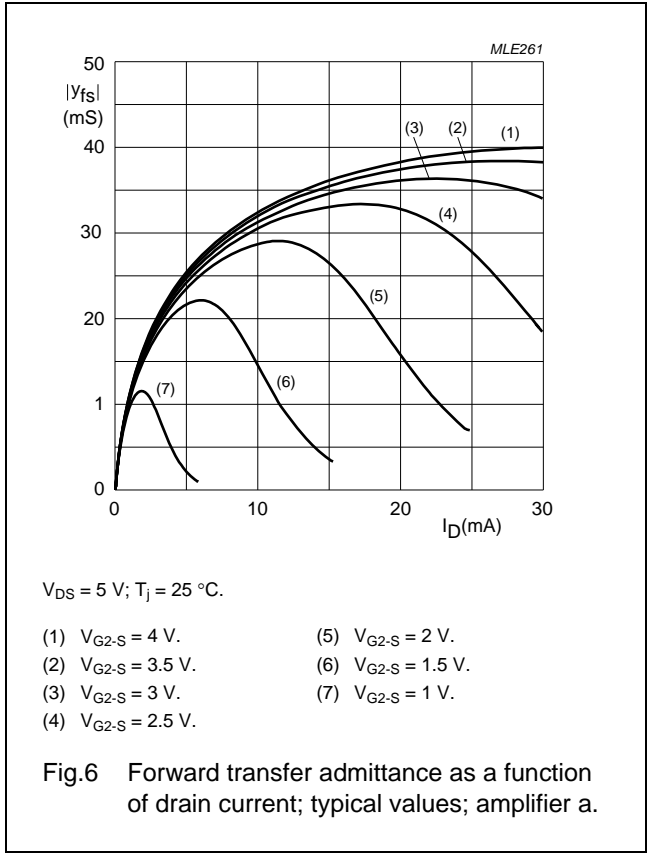
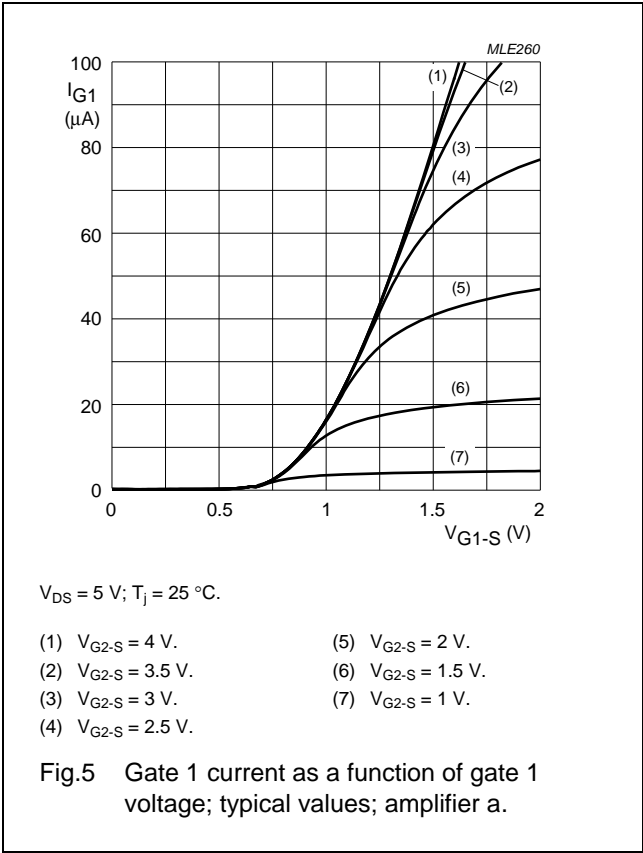
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GRAPHS FOR AMPLIFIER a



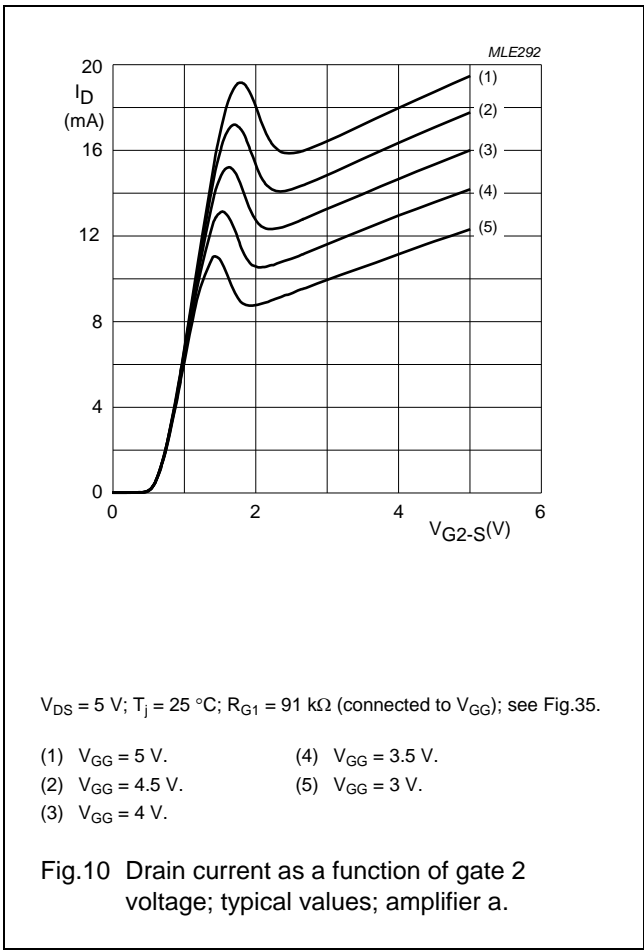
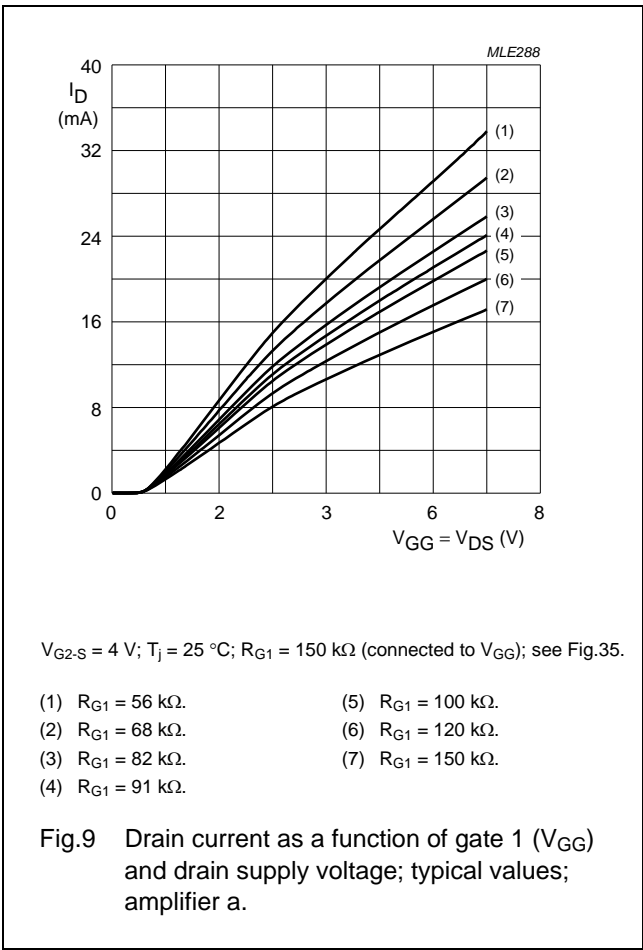
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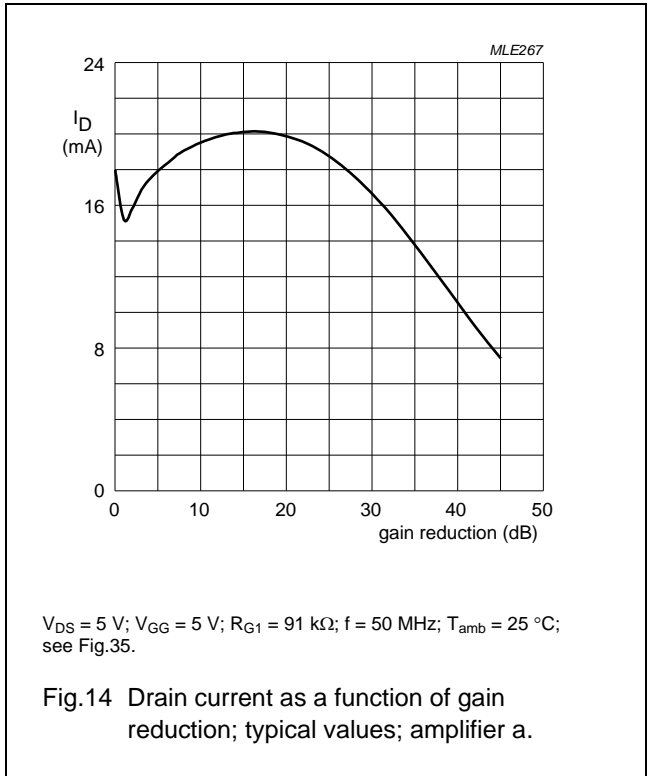
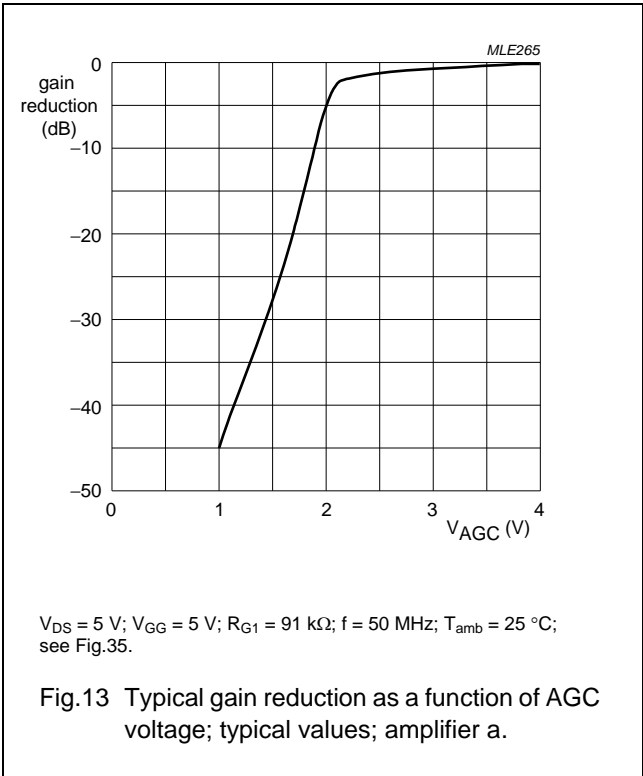
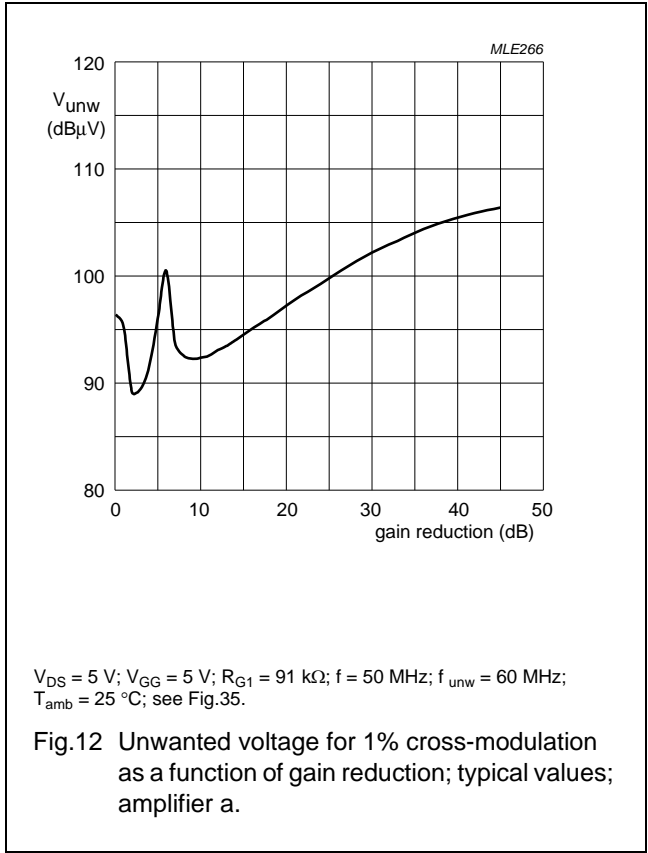
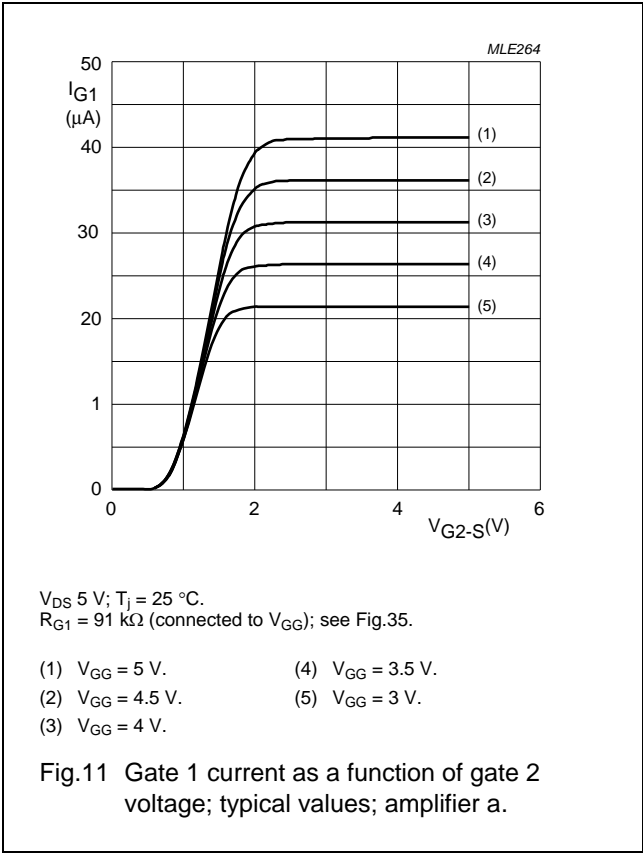
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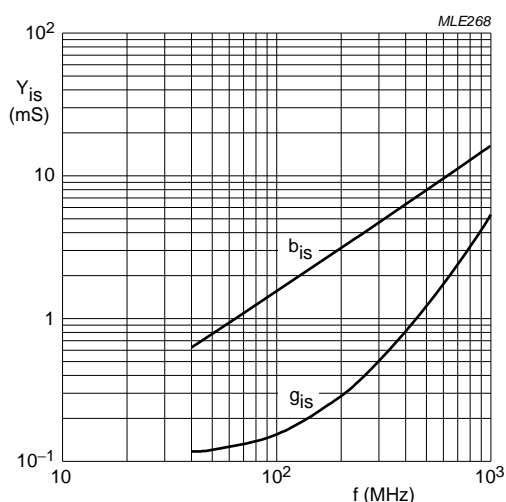
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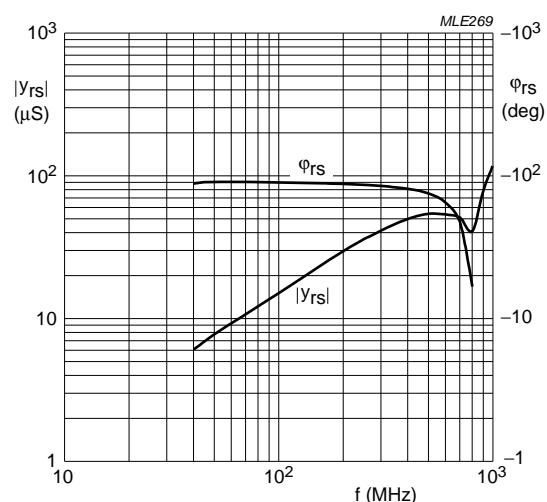
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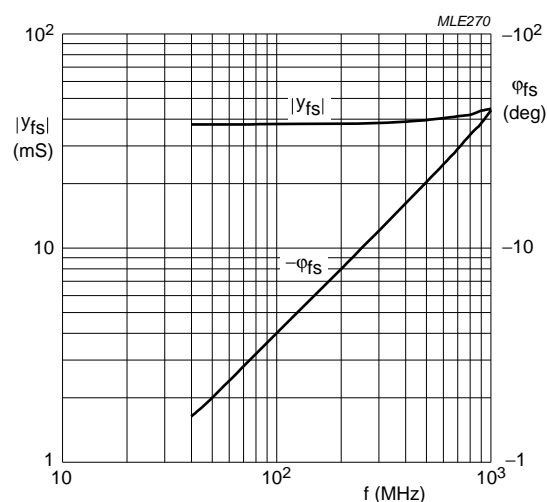
$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 18\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.15 Input admittance as a function of frequency; typical values; amplifier a.



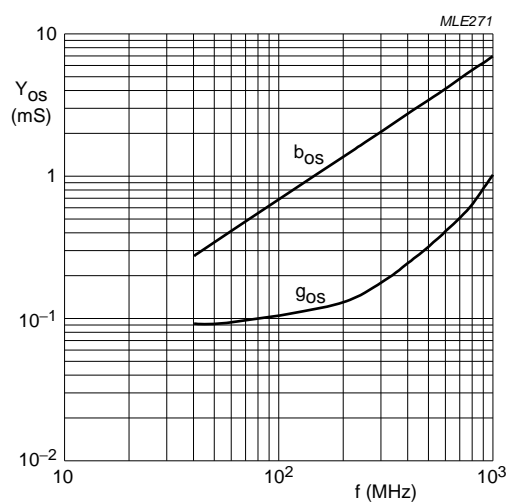
$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 18\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.16 Reverse transfer admittance and phase as a function of frequency; typical values; amplifier a.



$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 18\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.17 Forward transfer admittance and phase as a function of frequency; typical values; amplifier a.



$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 18\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.18 Output admittance as a function of frequency; typical values; amplifier a.

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Amplifier a scattering parameters

 $V_{DS} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_D = 18\text{ mA}$; $T_{amb} = 25\text{ °C}$

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) |
| 50 | 0.988 | -4.62 | 3.72 | 174.72 | 0.0008 | 86.73 | 0.991 | -2.07 |
| 100 | 0.984 | -9.23 | 3.71 | 169.42 | 0.0015 | 84.39 | 0.989 | -4.16 |
| 200 | 0.971 | -18.33 | 3.66 | 159.05 | 0.0029 | 79.96 | 0.986 | -8.24 |
| 300 | 0.951 | -27.32 | 3.58 | 148.77 | 0.0038 | 76.62 | 0.980 | -12.32 |
| 400 | 0.926 | -36.04 | 3.47 | 138.74 | 0.0044 | 74.42 | 0.973 | -16.33 |
| 500 | 0.896 | -44.50 | 3.36 | 129.05 | 0.0046 | 74.84 | 0.965 | -20.25 |
| 600 | 0.865 | -52.63 | 3.23 | 119.67 | 0.0043 | 79.73 | 0.958 | -24.20 |
| 700 | 0.832 | -60.47 | 3.09 | 110.43 | 0.0038 | 92.63 | 0.951 | -28.14 |
| 800 | 0.797 | -67.66 | 2.91 | 101.40 | 0.0028 | 118.47 | 0.937 | -32.14 |
| 900 | 0.769 | -75.01 | 2.83 | 93.09 | 0.0051 | 146.61 | 0.940 | -35.76 |
| 1000 | 0.732 | -81.73 | 2.67 | 84.05 | 0.0071 | 159.78 | 0.937 | -39.86 |

Noise data

 $V_{DS} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_D = 18\text{ mA}$; $T_{amb} = 25\text{ °C}$

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n (Ω) |
|------------|--------------------------|------------------|-------|-----------------------|
| | | (ratio) | (deg) | |
| 400 | 1.3 | 0.618 | 22.7 | 26.7 |
| 800 | 1.6 | 0.593 | 44.1 | 29.7 |

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DYNAMIC CHARACTERISTICS AMPLIFIER bCommon source; $T_{amb} = 25\text{ °C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS} = 5\text{ V}$; $I_D = 12\text{ mA}$; unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|------------------------------|---|------|------|------|------------|
| $ Y_{fs} $ | forward transfer admittance | pulsed; $T_j = 25\text{ °C}$ | 29 | 34 | 44 | mS |
| C_{ig1-ss} | input capacitance at gate 1 | $f = 1\text{ MHz}$ | – | 1.7 | 2.2 | pF |
| C_{ig2-ss} | input capacitance at gate 2 | $f = 1\text{ MHz}$ | – | 4.2 | – | pF |
| C_{oss} | output capacitance | $f = 1\text{ MHz}$ | – | 0.85 | – | pF |
| C_{rss} | reverse transfer capacitance | $f = 1\text{ MHz}$ | – | 15 | 30 | fF |
| F | noise figure | $f = 11\text{ MHz}$; $G_S = 20\text{ mS}$; $B_S = 0$ | – | 3.5 | – | dB |
| | | $f = 400\text{ MHz}$; $Y_S = Y_{S\text{ opt}}$ | – | 1.3 | 1.9 | dB |
| | | $f = 800\text{ MHz}$; $Y_S = Y_{S\text{ opt}}$ | – | 1.4 | 2 | dB |
| G_{tr} | power gain | $f = 200\text{ MHz}$; $G_S = 2\text{ mS}$; $B_S = B_{S\text{ opt}}$; $G_L = 0.5\text{ mS}$; $B_L = B_{L\text{ opt}}$; note 1 | – | 35 | – | dB |
| | | $f = 400\text{ MHz}$; $G_S = 2\text{ mS}$; $B_S = B_{S\text{ opt}}$; $G_L = 1\text{ mS}$; $B_L = B_{L\text{ opt}}$; note 1 | – | 31 | – | dB |
| | | $f = 800\text{ MHz}$; $G_S = 3.3\text{ mS}$; $B_S = B_{S\text{ opt}}$; $G_L = 1\text{ mS}$; $B_L = B_{L\text{ opt}}$; note 1 | – | 27 | – | dB |
| X_{mod} | cross-modulation | input level for $k = 1\%$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$; note 2 | | | | |
| | | at 0 dB AGC | 90 | – | – | dB μ V |
| | | at 10 dB AGC | – | 90 | – | dB μ V |
| | | at 40 dB AGC | 100 | 103 | – | dB μ V |

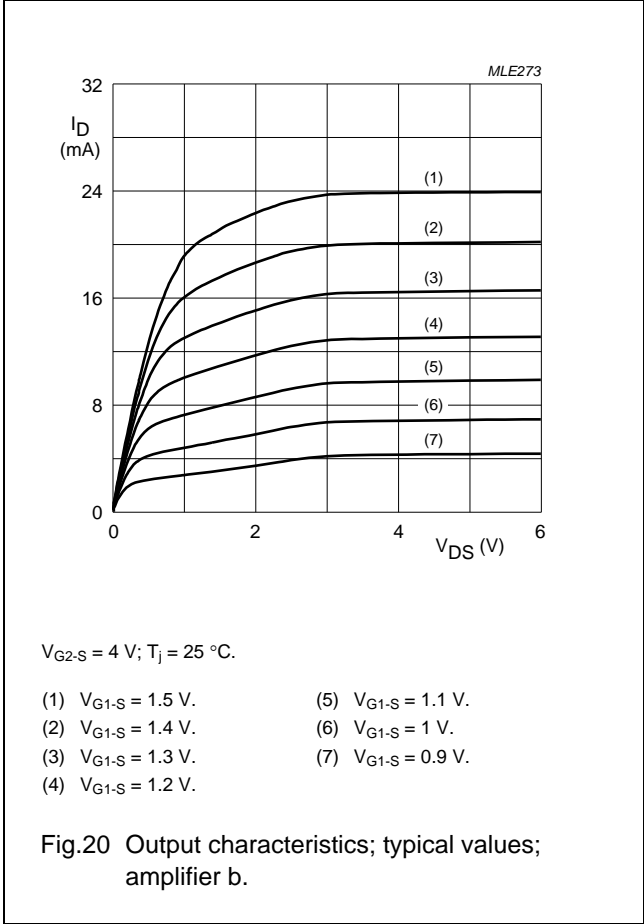
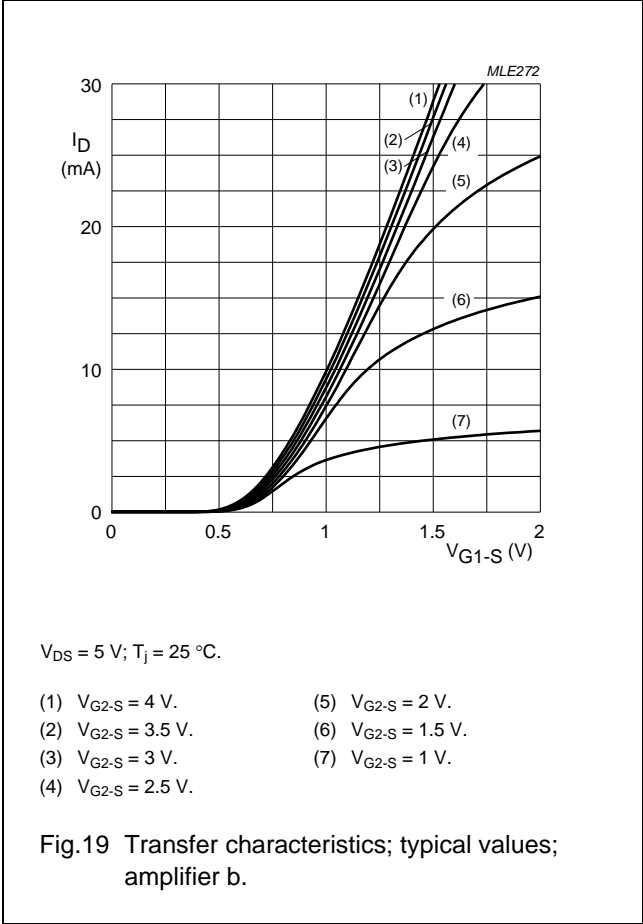
Notes

1. Calculated from measured s-parameters.
2. Measured in Fig.35 test circuit.

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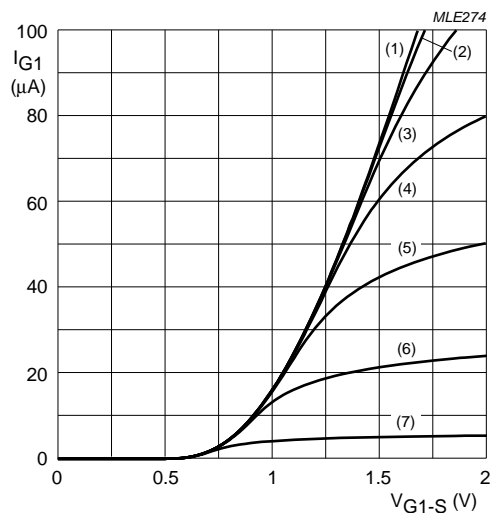
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GRAPHS FOR AMPLIFIER b



Dual N-channel dual-gate MOS-FET

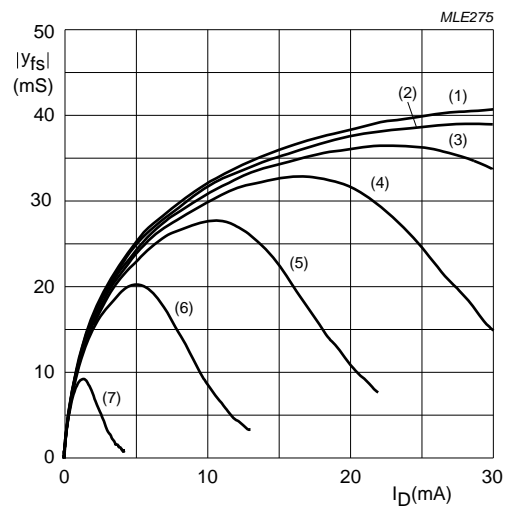
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$V_{DS} = 5 \text{ V}$; $T_j = 25 \text{ }^{\circ}\text{C}$.

- | | |
|----------------------------------|----------------------------------|
| (1) $V_{G2-S} = 4 \text{ V}$. | (5) $V_{G2-S} = 2 \text{ V}$. |
| (2) $V_{G2-S} = 3.5 \text{ V}$. | (6) $V_{G2-S} = 1.5 \text{ V}$. |
| (3) $V_{G2-S} = 3 \text{ V}$. | (7) $V_{G2-S} = 1 \text{ V}$. |
| (4) $V_{G2-S} = 2.5 \text{ V}$. | |

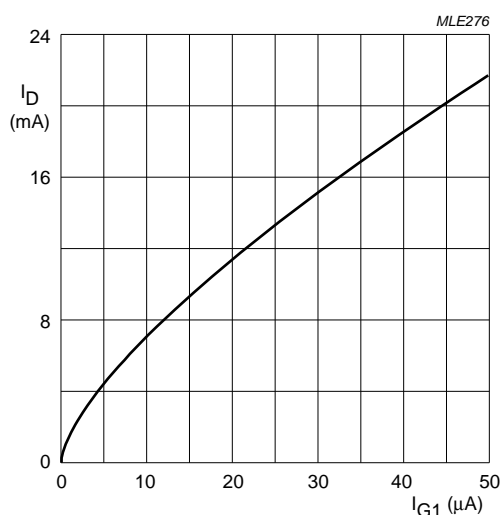
Fig.21 Gate 1 current as a function of gate 1 voltage; typical values; amplifier b.



$V_{DS} = 5 \text{ V}$; $T_j = 25 \text{ }^{\circ}\text{C}$.

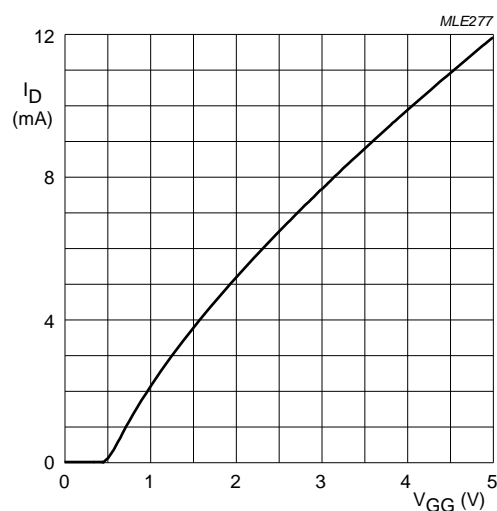
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|----------------------------------|----------------------------------|
| (1) $V_{G2-S} = 4 \text{ V}$. | (5) $V_{G2-S} = 2 \text{ V}$. |
| (2) $V_{G2-S} = 3.5 \text{ V}$. | (6) $V_{G2-S} = 1.5 \text{ V}$. |
| (3) $V_{G2-S} = 3 \text{ V}$. | (7) $V_{G2-S} = 1 \text{ V}$. |
| (4) $V_{G2-S} = 2.5 \text{ V}$. | |

Fig.22 Forward transfer admittance as a function of drain current; typical values; amplifier b.



$V_{DS} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $T_j = 25 \text{ }^{\circ}\text{C}$.

Fig.23 Drain current as a function of gate 1 current; typical values; amplifier b.

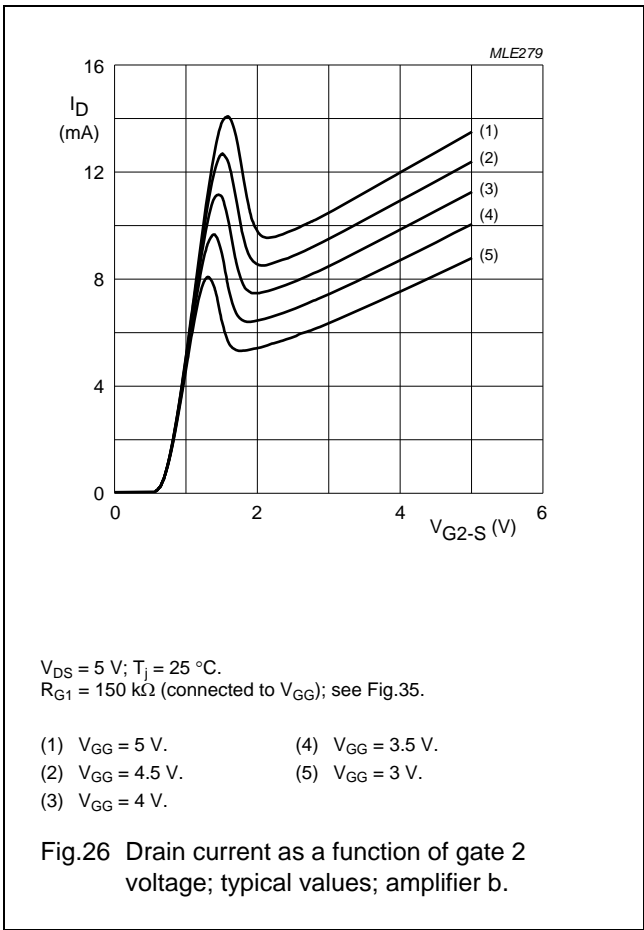
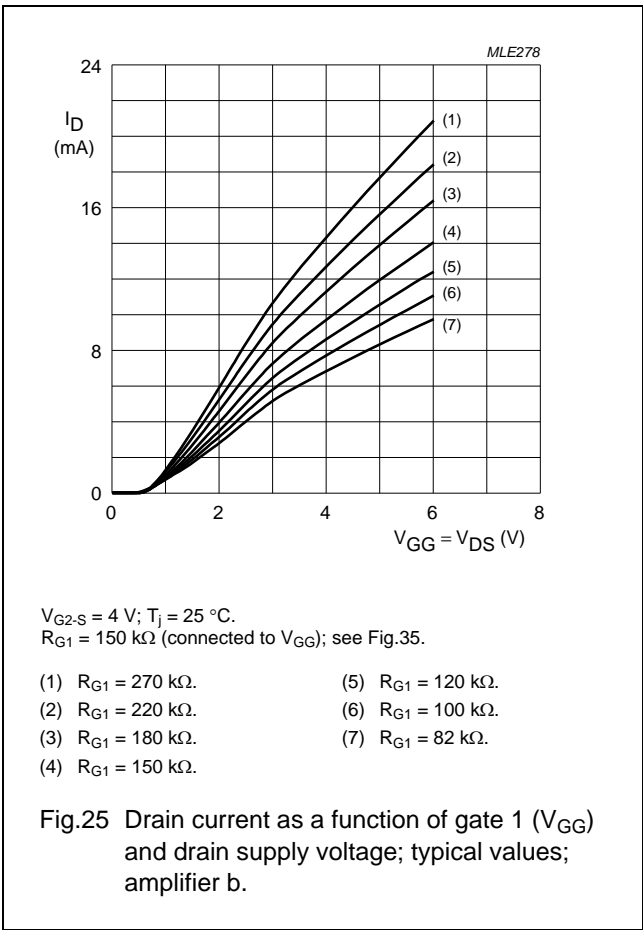


$V_{DS} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $T_j = 25 \text{ }^{\circ}\text{C}$.
 $R_{G1} = 150 \text{ k}\Omega$ (connected to V_{GG}); see Fig.35.

Fig.24 Drain current as a function of gate 1 supply voltage (V_{GG}); typical values; amplifier b.

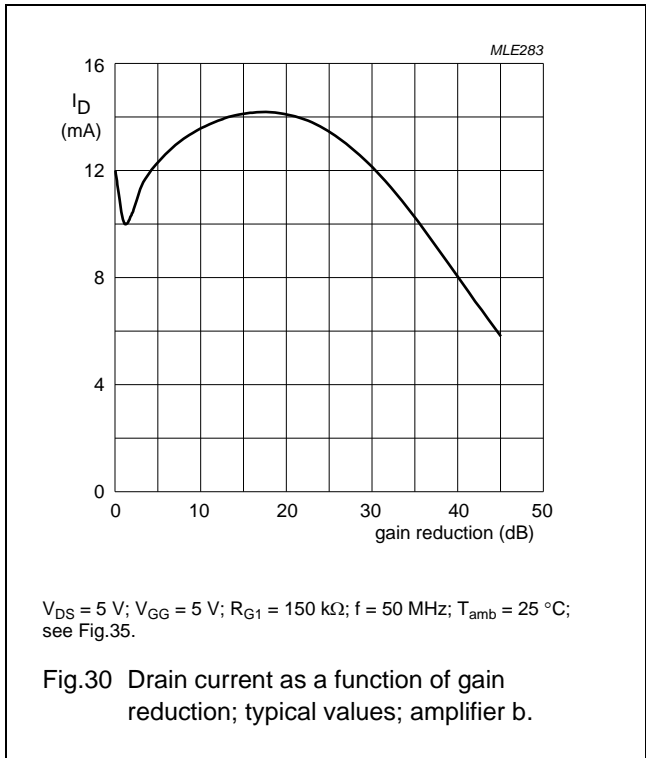
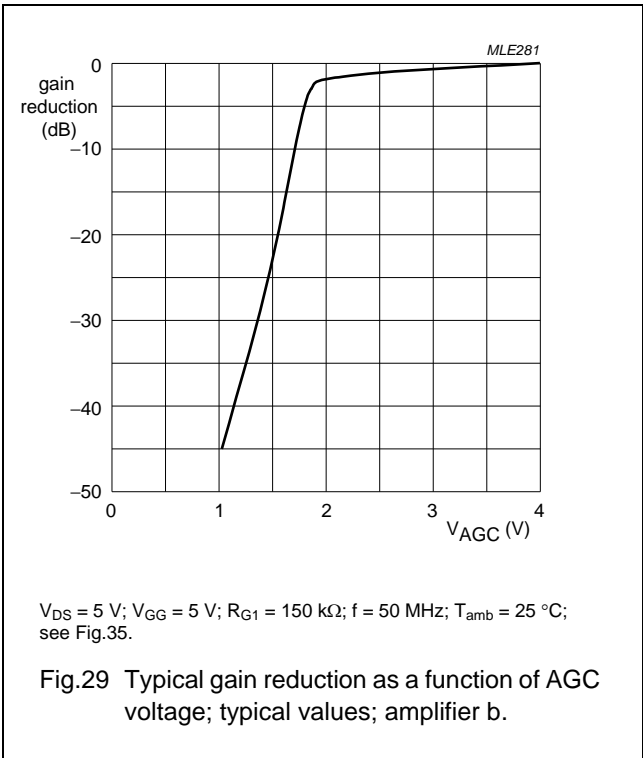
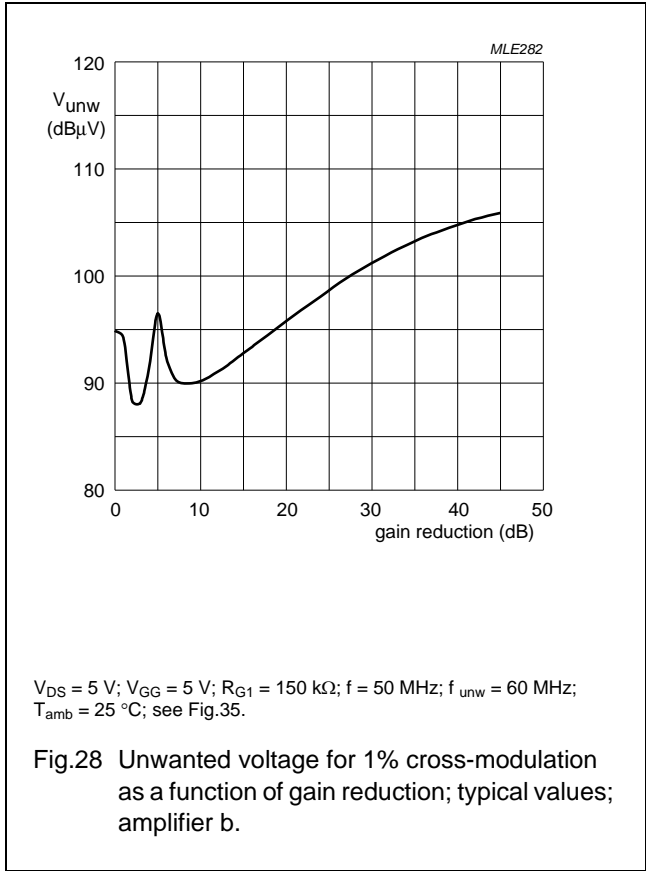
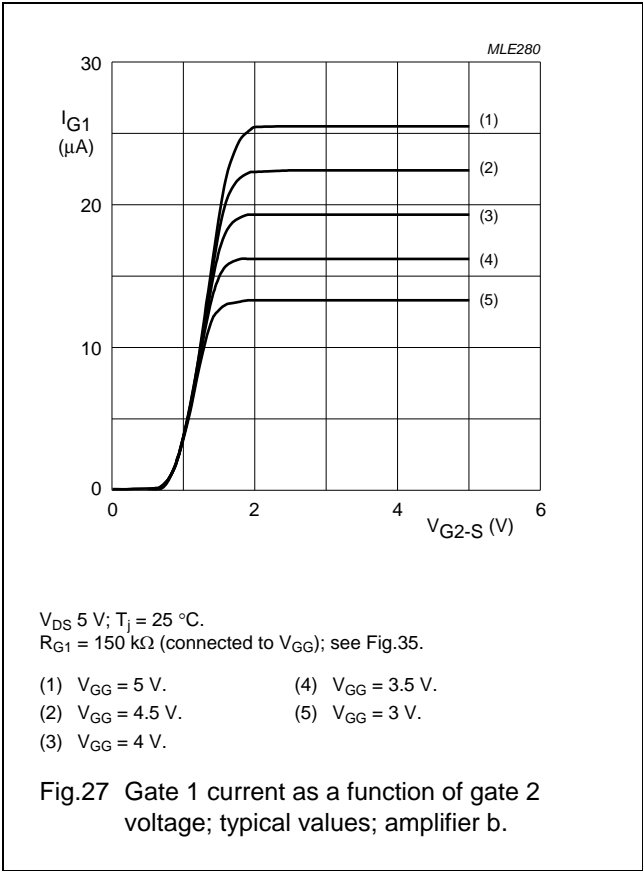
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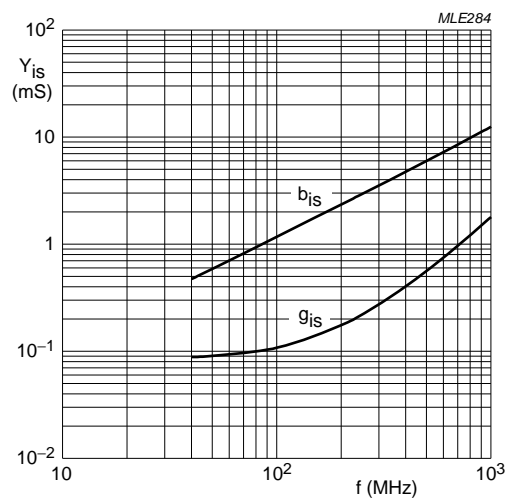
Dual N-channel dual-gate MOS-FET

BF1206



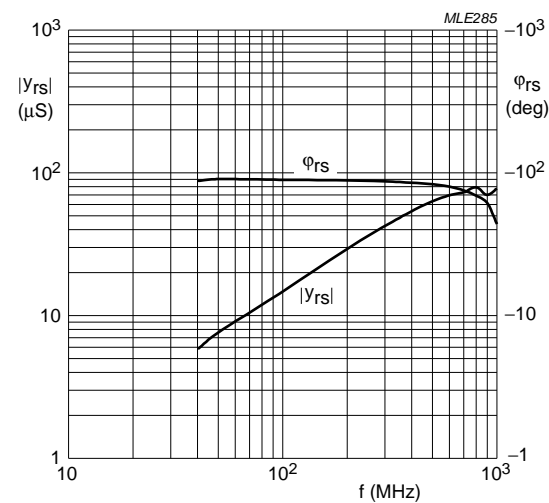
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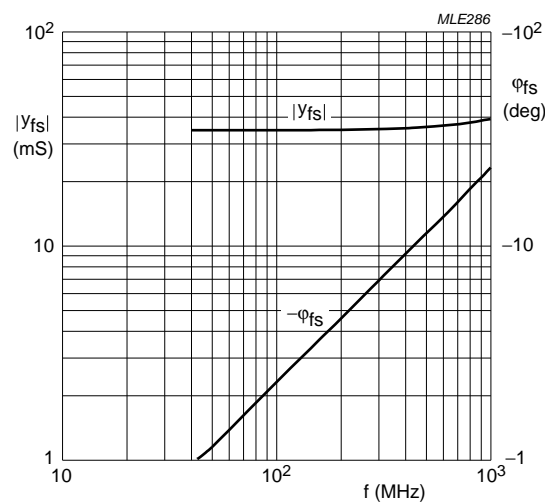
$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 12\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.31 Input admittance as a function of frequency; typical values; amplifier b.



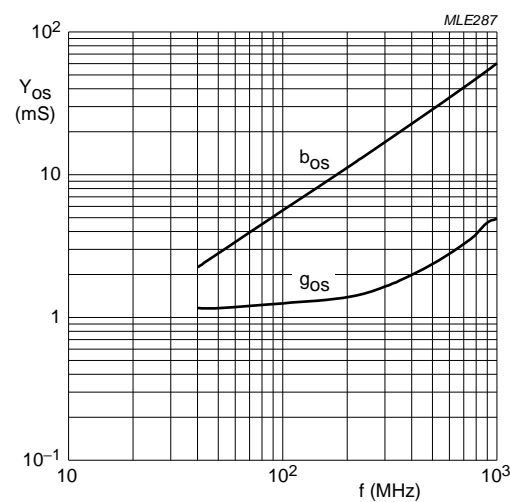
$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 12\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.32 Reverse transfer admittance and phase as a function of frequency; typical values; amplifier b.



$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 12\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.33 Forward transfer admittance and phase as a function of frequency; typical values; amplifier b.

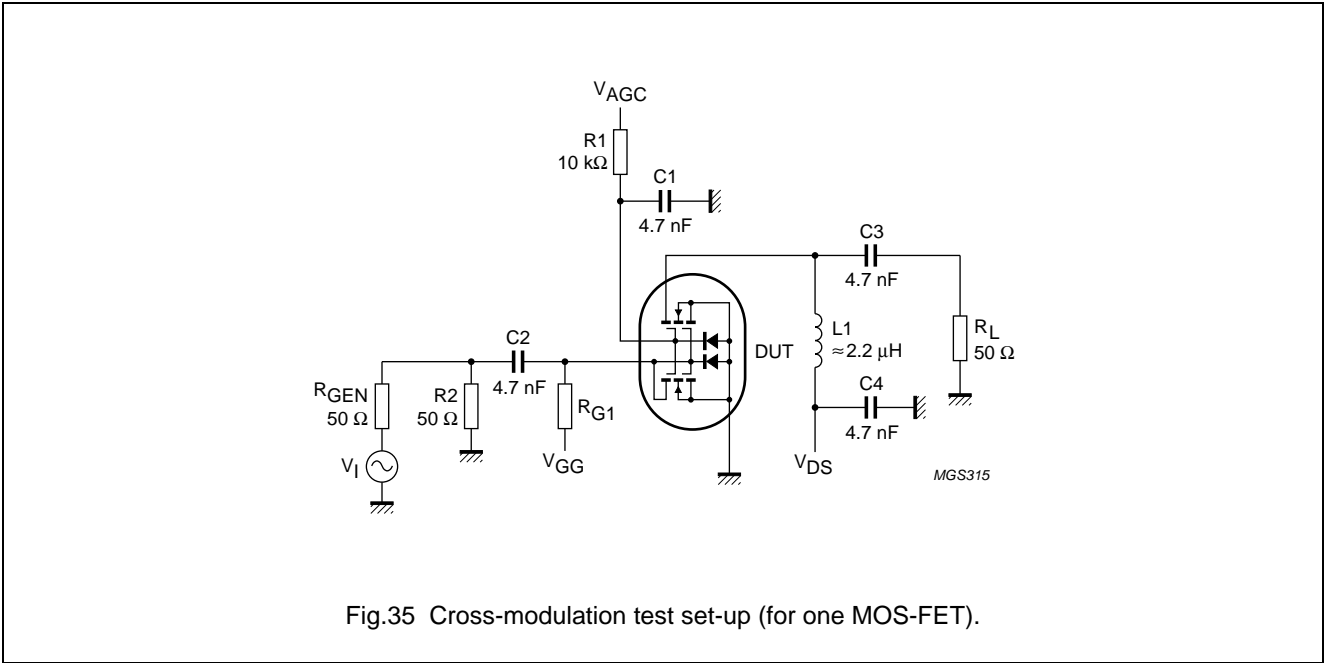


$V_{DS} = 5\text{ V}$; $V_{G2} = 4\text{ V}$; $I_D = 12\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig.34 Output admittance as a function of frequency; typical values; amplifier b.

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Amplifier b scattering parameters

$V_{DS} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_D = 12\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$

| f (MHz) | S11 | | S21 | | S12 | | S22 | |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) |
| 50 | 0.991 | -3.43 | 3.44 | 176.33 | 0.0008 | 86.54 | 0.988 | -1.69 |
| 100 | 0.989 | -6.84 | 3.43 | 172.66 | 0.0015 | 84.92 | 0.987 | -3.38 |
| 200 | 0.982 | -13.61 | 3.41 | 165.44 | 0.0029 | 80.95 | 0.985 | -6.72 |
| 300 | 0.973 | -20.37 | 3.38 | 158.20 | 0.0041 | 77.63 | 0.982 | -10.08 |
| 400 | 0.961 | -27.05 | 3.34 | 151.04 | 0.0051 | 74.43 | 0.978 | -13.46 |
| 500 | 0.947 | -33.68 | 3.29 | 144.02 | 0.0058 | 71.86 | 0.973 | -16.83 |
| 600 | 0.933 | -40.17 | 3.23 | 137.12 | 0.0062 | 70.28 | 0.969 | -20.25 |
| 700 | 0.919 | -46.54 | 3.16 | 130.22 | 0.0063 | 70.72 | 0.965 | -23.68 |
| 800 | 0.905 | -52.86 | 3.09 | 123.22 | 0.0065 | 72.37 | 0.960 | -27.22 |
| 900 | 0.890 | -58.60 | 3.02 | 116.84 | 0.0055 | 75.91 | 0.958 | -30.57 |
| 1000 | 0.881 | -64.34 | 2.94 | 110.20 | 0.0058 | 89.82 | 0.958 | -34.14 |

Noise data

$V_{DS} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_D = 12\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n (Ω) |
|------------|--------------------------|------------------|-------|-----------------------|
| | | (ratio) | (deg) | |
| 400 | 1.3 | 0.648 | 14.4 | 28.8 |
| 800 | 1.4 | 0.604 | 31.1 | 27.9 |

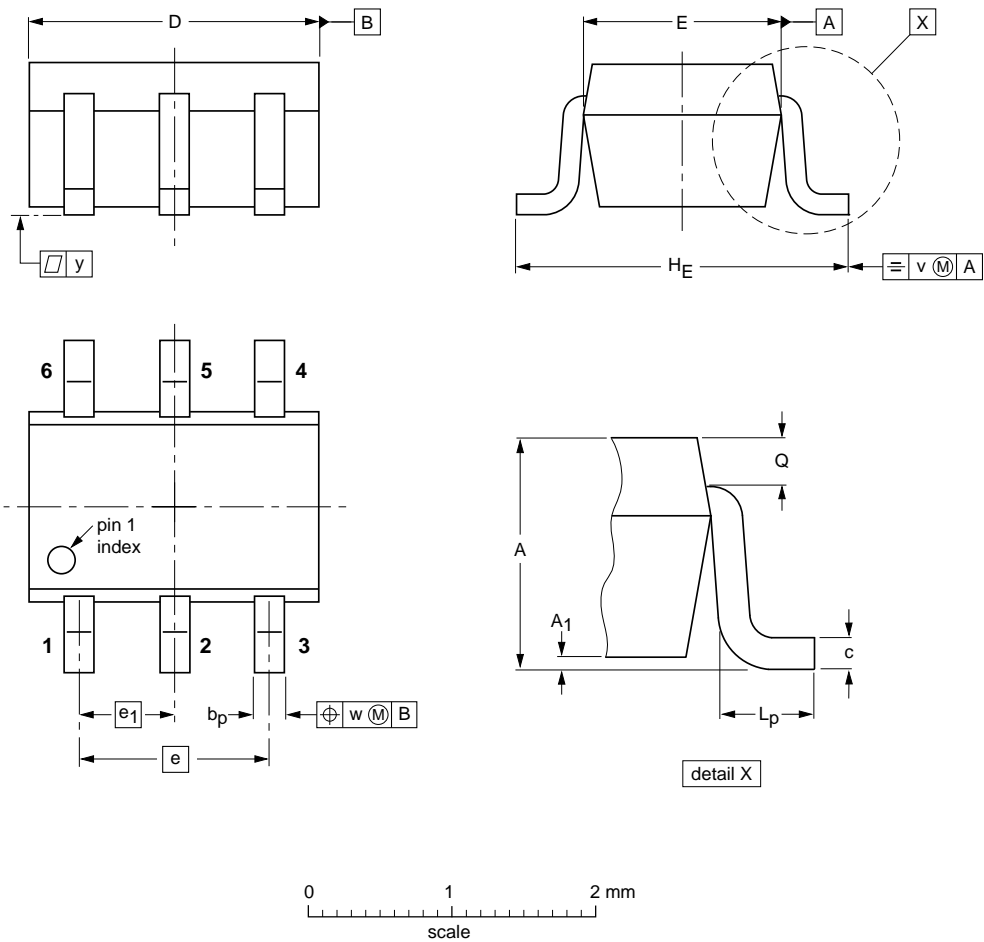
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PACKAGE OUTLINE

Plastic surface-mounted package; 6 leads

SOT363



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|-----------------------|----------------|--------------|------------|--------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.8 | 0.1 | 0.30 0.20 | 0.25 0.10 | 2.2 1.8 | 1.35 1.15 | 1.3 | 0.65 | 2.2 2.0 | 0.45 0.15 | 0.25 0.15 | 0.2 | 0.2 | 0.1 |

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|-------|-------|--|------------------------|----------------------|
| | IEC | JEDEC | JEITA | | | |
| SOT363 | | | SC-88 | | | 04-11-08 06-03-16 |

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DATA SHEET STATUS

| DOCUMENT STATUS ⁽¹⁾ | PRODUCT STATUS ⁽²⁾ | DEFINITION |
|--------------------------------|-------------------------------|---|
| Objective data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary data sheet | Qualification | This document contains data from the preliminary specification. |
| Product data sheet | Production | This document contains the product specification. |

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Contact information

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